DELIVERY SPECIFICATION

SPEC. No. C-General-h D A T E: Jun, 2020

То

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

Multilayer Ceramic Chip Capacitors

Bulk and tape packaging [RoHS compliant]

C1005,C1608,C2012,C3216,C3225,

C4532,C5750 Type

C0G,CH,X5R,X6S,X7R,X7S,X7T,B Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

■ CATALOG NUMBER CONSTRUCTION

С	3216	X5R	1A	107	М	160	Α	С
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)

(1) Series

(2) Dimensions L x W (mm)

Code	EIA	Length	Width	Terminal width
1005	CC0402	1.00	0.50	0.10
1608	CC0603	1.60	0.80	0.20
2012	CC0805	2.00	1.25	0.20
3216	CC1206	3.20	1.60	0.20
3225	CC1210	3.20	2.50	0.20
4532	CC1812	4.50	3.20	0.20
5750	CC2220	5.70	5.00	0.20

(6) Capacitance tolerance			
Code	Tolerance		
В	±0.10pF		
С	±0.25pF		
D	±0.50pF		
F	±1%		
G	±2%		
J	±5%		
K	±10%		
М	±20%		

Thickness

0.20mm 0.30mm

0.50mm

0.60mm

0.80mm

0.85mm

1.15mm

1.25mm

1.30mm

1.60mm

2.00mm

2.30mm

2.50mm

3.20mm

(7) Thickness

Code

020

030

060

080

085

115

125

130

160

200

230

250

320

(3) Temperature characteristics

Temperature	Temperature coefficient	Temperature
characteristics	or capacitance change	range
CH	0±60 ppm/℃	-25 to +85℃
COG	0±30 ppm/℃	-55 to +125℃
JB	±10%	-25 to +85℃
X5R	±15%	-55 to +85℃
X6S	±22%	-55 to +105℃
X7R	±15%	-55 to +125℃
X7S	±22%	-55 to +125℃

(4) Rated voltage (DC)

Code	Voltage (DC)
0G	4V
03	6.3V
1A	10V
1C	16V
1E	25V
1V	35V
1H	50V
1N	75V

280 2.80mm

(8) Packaging style

Code Style

A 178mm reel, 4mm pitch

B 178mm reel, 2mm pitch

K 178mm reel, 8mm pitch

(5) Nominal capacitance (pF)

The capacitance is expressed in three digit codes and in units of pico Farads (pF). The first and second digits identify the first and second significant figures of the capacitance. The third digit identifies the multiplier. R designates a decimal point.

(Example) 0R5 = 0.5pF101 = 100pF

 $225 = 2,200,000pF = 2.2\mu F$

(9) Special reserved code

Code	Description
A,B,C	TDK internal code

CATALOG NUMBER CONSTRUCTION

C	5750	X7S	2A	226	M	280	K	В	
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)	_

(1) Series

(2) Dimensions L x W (mm)

Code	EIA	Length	Width	Terminal width
1005	CC0402	1.00	0.50	0.10
1608	CC0603	1.60	0.80	0.20
2012	CC0805	2.00	1.25	0.20
3216	CC1206	3.20	1.60	0.20
3225	CC1210	3.20	2.50	0.20
4532	CC1812	4.50	3.20	0.20
5750	CC2220	5.70	5.00	0.20

(3) Temperature characteristics

(3) Temperature C	(3) Temperature characteristics				
Temperature	Temperature coefficient	Temperature			
characteristics	or capacitance change	range			
CH	0±60 ppm/℃	-25 to +85℃			
C0G	0±30 ppm/℃	-55 to +125℃			
JB	±10%	-25 to +85℃			
X5R	±15%	-55 to +85℃			
X6S	±22%	-55 to +105℃			
X7R	±15%	-55 to +125℃			
X7S	±22%	-55 to +125℃			
X7T	+22,-33%	-55 to +125℃			

(4) Rated voltage (DC)

Code	Voltage (DC)
2A	100V
2E	250V
2V	350V
2W	450V
2J	630V

(5) Nominal capacitance (pF)

The capacitance is expressed in three digit codes and in units of pico Farads (pF). The first and second digits identify the first and second significant figures of the capacitance. The third digit identifies the multiplier. R designates a decimal point.

(Example) 0R5 = 0.5pF101 = 100pF

 $225 = 2,200,000pF = 2.2\mu F$

(6) Capacitance tolerance

Code	Tolerance
С	±0.25pF
D	±0.50pF
F	±1%
G	±2%
J	±5%
K	±10%
М	±20%

(7) Thickness

Code	Thickness
050	0.50mm
060	0.60mm
080	0.80mm
085	0.85mm
115	1.15mm
125	1.25mm
130	1.30mm
160	1.60mm
200	2.00mm
230	2.30mm
250	2.50mm
280	2.80mm
320	3.20mm

(8) Packaging style

Code	Style
Α	178mm reel, 4mm pitch
В	178mm reel, 2mm pitch
K	178mm reel, 8mm pitch

(9) Special reserved code

· / !	
Code	Description
A.B.C.N	TDK internal code

SCOPE

This delivery specification	shall be applied to	Multilayer cerami	ic chip capacitors to	be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $C \diamondsuit \diamondsuit \diamondsuit O O \triangle \triangle \Box \Box \Box \times$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

CONTENTS

- 1. CODE CONSTRUCTION
- 2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE
- 3. OPERATING TEMPERATURE RANGE
- 4. STORING CONDITION AND TERM
- 5. P.C. BOARD
- 6. INDUSTRIAL WASTE DISPOSAL
- 7. PERFORMANCE
- 8. INSIDE STRUCTURE AND MATERIAL
- 9. PACKAGING
- 10. RECOMMENDATION
- 11. SOLDERING CONDITION
- 12. CAUTION
- 13. TAPE PACKAGING SPECIFICATION

<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

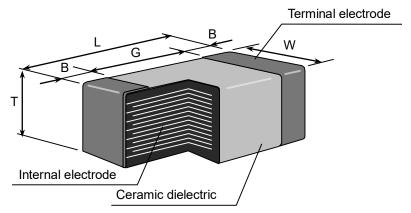
If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	Jun, 2020	C-general-h

1. CODE CONSTRUCTION

(Example) <u>C2012</u> <u>X7R</u> <u>1E</u> <u>225</u> <u>K</u> <u>T</u> <u>OOOO</u> (1) (2) (3) (4) (5) (6) (7)

(1) Case size



Case size	Dimensions (mm)				
[EIA style]	L	W	Т	В	G
	1.00±0.05	0.50±0.05	0.50±0.05		
C1005	1.00±0.10	0.50±0.10	0.50±0.10	0.10 min.	0.30 min.
[CC0402]	1.00 ^{+0.15} - 0.10	0.50 ^{+0.15} - 0.10	0.50 ^{+0.15} - 0.10	. O. 10 111111.	0.50 11111.
	1.60±0.10	0.80±0.10	0.80±0.10		
C1608 [CC0603]	1.60 ^{+0.15} - 0.10	0.80 ^{+0.15} - 0.10	0.80 ^{+0.15} - 0.10	0.20 min.	0.30 min.
	1.60 ^{+0.20} _{-0.10}	0.80 ^{+0.20} - 0.10	0.80 ^{+0.20} _{-0.10}		
			0.60±0.15		
C2012	2.00±0.20	1.25±0.20	0.85±0.15		
[CC0805]			1.25±0.20	0.20 min.	0.50 min.
	2.00 ^{+0.25} - 0.15	1.25 ^{+0.25} - 0.15	1.25 ^{+0.25} - 0.15		
			0.60±0.15		
C3216			0.85±0.15		
[CC1206]	3.20±0.20	1.60±0.20	1.15±0.15	0.20 min.	1.00 min.
			1.30±0.20		
			1.60±0.20		
	3.20 ^{+0.30} _{-0.10}	1.60 ^{+0.30} - 0.10	1.60 ^{+0.30} - 0.10		
			1.25±0.20		
			1.60±0.20		
C3225	3.20±0.40	2.50±0.30	2.00±0.20	0.20 min.	
[CC1210]			2.30±0.20		
			2.50±0.30		
	3.20 ^{+0.45} _{-0.40}	2.50 ^{+0.35} - 0.30	2.50 ^{+0.35} _{-0.30}		
C4532 [CC1812]			1.60±0.20		
			2.00±0.20	0.20 min.	
	4.50±0.40 3.	2 20 . 0 40	2.30±0.20		
		3.20±0.40	2.50±0.30		
			2.80±0.30		
			3.20±0.30		

^{*} As for each item, please refer to detail page on TDK web.

Case size	ize Dimensions (mm)				
[EIA style]	L	W	Т	В	G
C5750 [CC2220] 5.70±0.40		1.60±0.20			
			2.00±0.20		
	5.00±0.40	2.30±0.20	0.20 min.		
		2.50±0.30			
			2.80±0.30		

^{*} As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

(3) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 V	DC 350 V
2 E	DC 250 V
2 A	DC 100 V
1 N	DC 75 V
1 H	DC 50 V

Symbol	Rated Voltage
1 V	DC 35 V
1 E	DC 25 V
1 C	DC 16 V
1 A	DC 10 V
0 J	DC 6.3 V
0 G	DC 4V

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

(Example)

	,	
Symbo	ol	Rated Capacitance
2R2		2.2 pF
225		2,200,000 pF

(5) Capacitance tolerance

* M tolerance shall be standard for over 10uF.

Symbol	Tolerance	Capacitance
С	± 0.25 pF	10pF and under
D	± 0.5 pF	TOPE and under
J	± 5%	
K	± 10 %	Over 10pF
* M	± 20 %	

(6) Packaging

* C1005 type is applicable to tape packaging only.

Symbol	Packaging
В	Bulk
Т	Taping

(7) TDK internal code

^{*} Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitanc	e tolerance	Rated capacitance
		10pF and under	C (± 0.25pF)	1, 2, 3, 4, 5
1	C0G CH	Topr and under	D (± 0.5pF)	6, 7, 8, 9, 10
	OH	Over 10pF J (± 5 %		E – 6 series E – 12 series
	X5R X6S X7R	10uF and under	K (± 10 %) M (± 20 %)	E. Ourier
2	2 X7S X7T Over 2		M (± 20 %)	E – 6 series

Capacitance Step in E series

E series		Capacitance Step										
E- 6	1.	1.0 1.5 2.2 3.3 4.7					6	.8				
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
CH/B	-25°C	85°C	20°C
X5R	-55°C	85°C	25°C
X6S	-55°C	105°C	25°C
C0G/X7R/X7S/X7T	-55°C	125°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225[CC1210] and larger are more likely to be affected by heat stress from the substrate.

Please inquire separate specification for the large case sizes when mounted on the substrate.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

7. PERFORMANCE

table 1

No.	Iten	n	Performance		Test or inspection	n method		
1	External App	pearance	No defects which may affect performance.	Inspect with magnifying glass (3×)				
2 Insulation Resistance			Please refer to detail page on TDK web.	Measuring voltage: Rated voltage (As for the capacitor of rated voltage 630V DC, apply 500V DC.) Voltage application time: 60s.				
3	Voltage Prod	of	Withstand test voltage without insulation breakdown or other damage.		Rated voltage(RV) RV≦100V 100V <rv≦500v 100v<rv≦500v="" 500v<rv="" :="" application="" curre<="" discharge="" rv≦100v="" td="" time=""><td>Apply voltage 3 × rated voltage 1.5 × rated voltage 1.3 × rated voltage 2.5 × rated voltage 1.5 × rated voltage 1.5 × rated voltage 1.5 × rated voltage 1.6 × rated voltage 1.7 × rated voltage 1.8 × rated voltage</td></rv≦500v>	Apply voltage 3 × rated voltage 1.5 × rated voltage 1.3 × rated voltage 2.5 × rated voltage 1.5 × rated voltage 1.5 × rated voltage 1.5 × rated voltage 1.6 × rated voltage 1.7 × rated voltage 1.8 × rated voltage		
4	Capacitance	:	Within the specified tolerance.		neasuring condition, es representative.	please contact with		
5	Q	Class1	Please refer to detail page on TDK web.	See No.	4 in this table for n.	measuring		
	Dissipation Factor	Class2						

No.	Item	P	Perforr	mance	Test or inspection method
6	Temperature Characteristics of Capacitance (Class1)	T.C. COG CH Capacitand drift	ce V	rature Coefficient (ppm/°C) 0 ± 30 0 ± 60 Vithin ± 0.2% or 0.05pF, whichever larger.	Temperature coefficient shall be calculated based on values at 25°C(CH:20°C) and 85°C temperature. Measuring temperature below 25°C(CH:20°C) shall be -10°C and -25°C.
7	Temperature Characteristics of Capacitance (Class2)	No volta applied X5R: X6S: X7R: X7S: X7T:	ige	Change (%) With voltage Applied Please contact with our sales representative.	Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. ΔC be calculated ref. STEP3 reading Step Temperature(°C) 1 Reference temp. ± 2 2 Min. operating temp. ± 2 3 Reference temp. ± 2 4 Max. operating temp. ± 2 As for Min./Max. operating temp and Reference temp., please refer to "3. OPERATING TEMPERATURE RANGE" Apply a voltage of 1/2 rated voltage. As for measuring voltage, please contact with our sales representative.
8	Robustness of Terminations	No sign of tel breakage of o abnormal sig	ceram	tion coming off, ic, or other	Reflow solder the capacitors on a P.C.Board shown in Appendix 2. Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.board. Pushing force: 5N (2N is applied for C1005 type.) Holding time: 10±1s Pushing force P.C.Board
9	Bending	No mechanic	cal dar	mage.	Reflow solder the capacitors on a P.C.Board shown in Appendix1 and bend it for 1mm.

COIL	nuea)							
No.	Ite	em		Perf	ormance	Test o	or inspection method	
10	Solderability		termination	on. / have p	over over 75% of oin holes or rough ncentrated in one	Solder : Flux :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
			_		of A sections shall	Solder temp. :	245±5°C (Sn-3.0Ag-0.5Cu)	
				•	due to melting or ation material.	Dwell time :	3±0.3s.(Sn-3.0Ag-0.5Cu)	
					A section	Solder position :	Until both terminations are completely soaked.	
11	Resistance	External	No crack	s are a	llowed and	Solder :	Sn-3.0Ag-0.5Cu	
	to solder heat	appearance			all be covered at new solder.	Flux :	Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
		Capacitance	Charac	teristics	Change from the value before test	Solder temp. :	260±5°C	
			Class 1	C0G CH	Capacitance drift within ±2.5% or ±0.25pF, whichever larger.	Dwell time : Solder	10±1s.	
	X5R X6S Class X7R 2 X7S X7T			position : Pre-heating :	Until both terminations are completely soaked. Temp. — 110~140°C Time — 30~60s.			
				В	_			
		Q (Class1)	Meet the	initial s	spec.	Leave the cap condition for Class 1: 6~24	acitors in ambient	
		D.F. (Class2)	Meet the initial spec. Meet the initial spec.				Class 2 : 24±2h before measurement.	
		Insulation Resistance						
		Voltage proof	No insula damage.		eakdown or other			

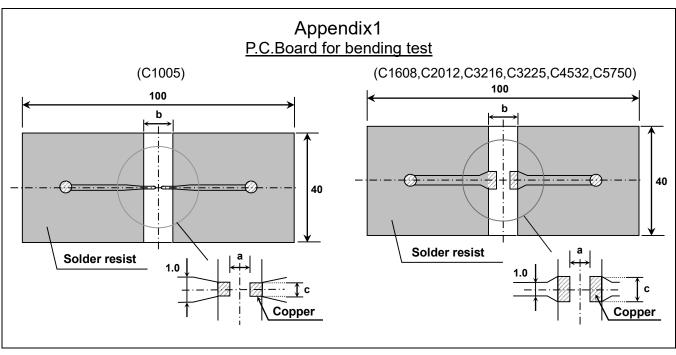
No.	110	Item Performance				Test or inspection method														
12	Vibration	External No mechanical damage. appearance					ency : 10~55~10Hz rocating sweep time :	1 min.												
		Capacitance	Charact	eristics	Change from the value before test	Repea	Amplitude: 1.5mm Repeat this for 2h each in 3 perpendicular directions(Total 6h).													
															Class1	C0G CH X5R X6S	±2.5% or ±0.25pF, whichever larger.	Reflov	v solder the capacitor	s on a
			Class2	X7R X7S X7T B	± 7.5 %	testing	• • • • • • • • • • • • • • • • • • • •	IIX 2 DOTOTO												
		Q (Class1)	Meet the																	
		D.F. (Class2)	Meet the	initial	spec.															
13	Temperature cycle	External appearance	No mech	anical	damage.	step1	Expose the capacitors in the condition step1 through step 4 listed in the following table.													
		Сараспансе	Сараспапсе	Capacitance	Charact		Change from the value before test		cycle : 5 cycles											
			Class1	C0G CH		Step	Temperature(°C)	Time (min.												
								Class	G 0	Class 2 X0S with	Please contact with our sales	1	Min. operating temp.±3	30 ± 3						
			Class2	X7S X7T	representative	2	Ambient Temp.	2 ~ 5												
									B		3	Max. operating temp.±2	30 ± 2							
		Q Meet the initial spec. (Class1)					4 Ambient Temp. 2 ~ 5													
		D.F. (Class2)			spec.	As for Min./Max. operating temp., please refer to "3. OPERATING														
		Insulation Resistance	Meet the	initial	spec.	TEMPERATURE RANGE" Leave the capacitors in ambient														
		Voltage proof	No insula damage.		eakdown or other	condition for Class 1 : 6~24h Class 2 : 24±2h before measurement.														
							v solder the capacitor pard shown in Append J.													

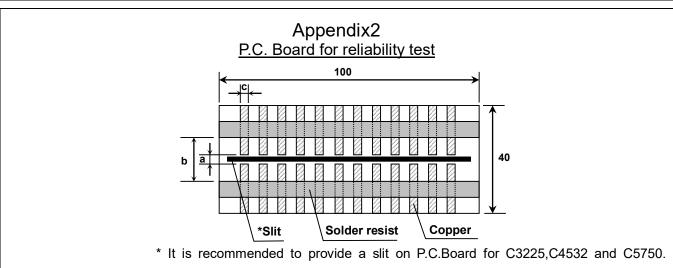
No.	It	em		Perfor	mance	Test or inspection method
14	Moisture Resistance	External appearance	No mechanical damage.			Test temp.: 40±2°C Test humidity: 90~95%RH
	(Steady State)	Capacitance	Characte	eristics	Change from the value before test	Test time : 500 +24,0h Leave the capacitors in ambient condition for
			Class1	C0G CH		Class 1 : 6~24h
			Class2	X6S	Please contact with our sales representative.	Class 2 : 24±2h before measurement. Reflow solder the capacitors on a
				X7T B		P.C.Board shown in Appendix2 before testing.
		Q (Class1)	Capad	citance	Q	
		(Class1)	30pF a	nd over	350 min.	
				10pF and over under 30pF 275+5/2xC min.		
			Unde	r 10pF	200+10×C min.	
			C : Rate	ed capac	citance (pF)	
		D.F. (Class2)	200% of in	itial spe	c. max.	
		Insulation Resistance	Please con representati		our sales	

No.	It	em		Perfo	rmance	Test or inspection method			
15	Moisture Resistance	External appearance	No mecha	nical da	amage.	Test temp.: 40±2°C Test humidity: 90~95%RH Applied voltage: Rated voltage			
		Capacitance	Characte	eristics	Change from the value before test	Test time: 500 +24,0h Charge/discharge current: 50mA or lower			
			Class1	C0G CH		Leave the capacitors in ambient condition for			
			Class2	X5R X6S X7R X7S X7T B	Please contact with our sales representative.	Class 1 : 6~24h Class 2 : 24±2h before measurement. Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.			
		Q (Class1)	Capa	citance	Q	Initial value setting (only for class 2)			
		(Class1)	(Classi)	(Classi)	(Classi)	30pF a	and over	200 min.	Voltage conditioning 《After voltage treat the capacitors under testing
			Under 30pF 100-			temperature and voltage for 1 hour,			
			C : Rate	ed capa	citance (pF)	leave the capacitors in ambient condition for 24±2h before			
		D.F. (Class2)	200% of initial spec. max.			measurement. Use this measurement for initial value.			
		Insulation Resistance	Please cor representat		n our sales				

JOHU	nued)						
No.	I	Item		Perfo	ormance	Test or inspection method	
16	Life	External appearance	No mecha	inical d	amage.	Test temp. : Maximum operating temperature±2°C Applied voltage : Please contact	
		Capacitance	Characteristics Change from the value before test			with our sales representative. Test time: 1,000 +48,0h	
			Class1	C0G CH		Charge/discharge current : 50mA or lower	
			Class2	Class2 X5R X6S X7R X7S X7T B	Leave the capacitors in ambient condition for Class 1 : 6~24h Class 2 : 24±2h before measurement		
		Q				Reflow solder the capacitors on a P.C.Board shown in Appendix2 before	
		(Class1)	Capac	itance	Q	testing.	
			30pF ar		350 min.	Initial value setting (only for class 2)	
			10pF ar under		275+5/2×C min.	Voltage conditioning 《After voltage treat the capacitors under testing	
			Under	10pF	200+10×C min.	temperature and voltage for 1 hour	
			C : Rated capacitance (pF)			leave the capacitors in ambient condition for 24±2h before	
		D.F. (Class2)	200% of ir	nitial spe	ec. max.	measurement. Use this measurement for initial value.	
		Insulation Resistance	Please contact with our sales representative.		n our sales		

^{*}As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14, leave capacitors at $150 \, 0,-10 \, ^{\circ}$ C for 1 hour and measure the value after leaving capacitors for 24 ± 2h in ambient condition.





			(Unit : mm)
Symbol Case size	а	b	С
C1005 [CC0402]	0.4	1.5	0.5
C1608 [CC0603]	1.0	3.0	1.2
C2012 [CC0805]	1.2	4.0	1.65
C3216 [CC1206]	2.2	5.0	2.0
C3225 [CC1210]	2.2	5.0	2.9
C4532 [CC1812]	3.5	7.0	3.7
C5750 [CC2220]	4.5	8.0	5.6

1. Material : Glass Epoxy(As per JIS C6484 GE4)

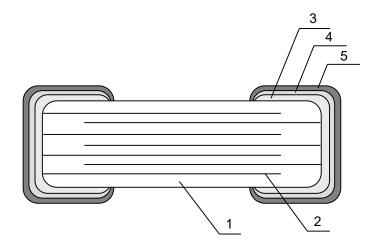
2. Thickness: Appendix 1 — 0.8mm (C1005)

— 1.6mm (C1608,C2012,C3216,C3225,C4532,C5750)

: Appendix 2 — 1.6mm

Copper(Thickness:0.035mm)
Solder resist

8. INSIDE STRUCTURE AND MATERIAL



No	NAME	MATERIAL		
No.	INAIVIE	Class1	Class2	
1	Dielectric	CaZrO₃	BaTiO₃	
2	Electrode	Nickel (Ni)		
3		Copper (Cu)		
4	Termination	Nickel (Ni)		
5		Tin (Sn)		

9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 9.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.
- 9.2 Tape packaging is as per 13. TAPE PACKAGING SPECIFICATION.
 - *C1005[CC0402] type is applicable to tape packaging only.
 - 1) Inspection No.*
 - 2) TDK P/N
 - 3) Customer's P/N
 - 4) Quantity

*Composition of Inspection No.

Example F 0 A - 23 - 001(a) (b) (c) (d) (e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

*Composition of new Inspection No.

(Implemented on and after May 1, 2019 in sequence)

- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day $(00 \sim ZZ)$
- (g) Suffix($00 \sim ZZ$)

10. RECOMMENDATION

As for C3225[CC1210] and larger, It is recommended to provide a slit (about 1mm width) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

11. SOLDERING CONDITION

As for C1005[CC0402], C3225[CC1210] and larger, reflow soldering only. For other case sizes than the above, reflow soldering is recommended.

^{*} It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases. Until the shift is completed, either current or new composition of inspection No. will be applied.

12. CAUTION

No.	Process	Condition
1	Operating Condition (Storage, Use,	1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature
	<u> </u>	Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		2) Do not use capacitors above the maximum allowable operating temperature. Surface temperature including self heating should be below maximum operating temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)
		The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.
		2-2. When overvoltage is applied
		Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature.

No.	Process	Condition					
2	Circuit design Caution	 2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V0-P must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, VP-P must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage. 					
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage					
		Positional Measurement (Rated voltage) 0 V _{0-P} 0					
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)					
		Positional Measurement (Rated voltage)					
		2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced. 3) The effective capacitance will vary depending an applied DC and AC voltages.					
		3) The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.					
		4) Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall no exceed the rated voltage.					
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.					
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.					

No.	Process	Condition						
3	Designing P.C.board	l capacitors						
		Avoid using commo solder land for each		or multiple termi	nations and pr	ovide individual		
		3) Size and recommer	nded land dime	nsions.				
			Chip o	capacitors Sold	er land			
		Solder resist						
		Reflow soldering				(Unit : mm)		
		Case size	C1005 [CC0402]	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC1206]		
		A	0.3 ~ 0.5	0.6 ~ 0.8	0.9 ~ 1.2	2.0 ~ 2.4		
		В	0.35 ~ 0.45	0.6 ~ 0.8	0.7 ~ 0.9	1.0 ~ 1.2		
		C	0.4 ~ 0.6	0.6 ~ 0.8	0.9 ~ 1.2	1.1 ~ 1.6		
		Case size	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]	-		
		A	2.0 ~ 2.4	3.1 ~ 3.7	4.1 ~ 4.8	-		
		B	1.0 ~ 1.2	1.2 ~ 1.4	1.2 ~ 1.4	-		
		C	1.9 ~ 2.5	2.4 ~ 3.2	4.0 ~ 5.0	-		
		Flow soldering (Un	Flow soldering (Unrecommend)			nm)		
		Case size Symbol	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC120			
		A	0.7 ~ 1.0	1.0 ~ 1.3	2.1 ~ 2	.5		
		В	0.8 ~ 1.0	1.0 ~ 1.2	1.1 ~ 1	.3		
		C	0.6 ~ 0.8	0.8 ~ 1.1	1.0 ~ 1	.3		

No.	Process		Condition				
3	Designing P.C.board	4) Recommende	4) Recommended chip capacitors layout is as following.				
			Disadvantage against bending stress	Advantage against bending stress			
		Mounting face	Perforation or slit	Perforation or slit			
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.			
			Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit			
		Chip arrangement (Direction)	Perforation or slit	Perforation or slit			
			Closer to slit is higher stress	Away from slit is less stress			
		Distance from slit	$\begin{array}{c c} \mathcal{Q}_1 \\ \hline \\ \hline \\ \end{array} $ $(\ \mathcal{Q}_1 < \mathcal{Q}_2\)$	$\begin{array}{c c} & \mathcal{Q}_2 \\ & \vdots $			
			1				

Process Condition No. 3 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. Designing P.C.board E Perforation 0000 00000 В Stress force A>B>EA>D>ESlit A > CWhen dividing printed wiring boards, the intensities of mechanical stress applied to capacitors are different according to each dividing method in the order of : Push-back < Slit < V-groove < Perforation. Therefore consider not only position of capacitors, but also the way of the dividing the printed wiring boards. 6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder land Chip Excessive solder Solder Need to avoid Excessive solder Solder land Solder Missing solder Lead wire Solder resist Solder resist Recommendation Solder resist $Q_2 > Q_1$

No.	Process	Condition					
4	Mounting	If the mounting he capacitors to result) Adjust the botto	 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions. 1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it. 				
		2) Adjust the mounting head pressure to be 1 to 3N of static weight.					
		To minimize the support from the See following experience.	ead, it is important to provide				
			Not recommended Recor				
		Single-sided mounting		Crack	Support pin is not to be underneath the capacitor.		
		Double-sides mounting	Solde	er Crack	Support pin		
	j	When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.					
		4-2. Amount of adh	<u></u>	**************************************	b		
		=		c			
			Example : 0	C2012 [CC0805], C3	216 [CC1206]		
			а	0.2mm m	in.		
			b	70 ~ 100 _k			
		-	С	Do not touch the	solder land		

No.	Process		Condition			
5	Soldering	5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux.				
		It is recommended to use a m Strong flux is not recommended	ux (less than 0.1wt% chlorine).			
		2) Excessive flux must be avoide	d. Please provide pro	pper amount of flux.		
		3) When water-soluble flux is use	ed, enough washing is	s necessary.		
		5-2. Recommended soldering pro Refer to the following temperatu		oldering.		
			Reflow soldering			
		< Pri	Soldering eheating Value Value	ral cooling		
		Peak Temp				
		Temp. (°C)	ΔT ΔT			
		Reflow soldering is recommend soldering is allowed for other ca		C3216 types, but only reflow		
		5-3. Recommended soldering pea Pb free solder is recommended		-		
		Temp./Duration	Reflow se	oldering		
		Solder Peak temp(°C) Duration(sec.) Lead Free Solder 260 max. 10 max.		Duration(sec.)		
				10 max.		
		Sn-Pb Solder	Sn-Pb Solder 230 max. 20 max. Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu			
		·				

No.	Process			Condition		
5	Soldering	5-4. Soldering profile : Flow Refer to the following tem		•	dering.	
		Peak Temp ()°) dway 0	Peak Temp (O o o o o o o o o o o o o o o o o o o o		al cooling or 60 sec. 3,C2012,C3216 types.	
			ecommended soldering peak temp and peak temp duration for Floree solder is recommended, but if Sn-37Pb must be used, refer to			_
		Johnpada	-	Flow sol	Flow soldering	
		Solder		Peak temp(°C)	Duration	n(sec.)
		Lead Free Solo	der	260 max.	5 ma	ax.
		Sn-Pb Solder		250 max.	3 ma	ax.
			•			
		Soldering		Case size		Temp. (°C)
		Reflow soldering	Reflow soldering C1005(CC0402),C160 C2012(CC0805),C321 C3225(CC1210), C453 C5750(CC2220)		805),C3216(CC1206)	
					ŕ	ΔT ≦ 130
		Flow soldering		8(CC0603),C2012(CC0 6(CC1206)	9805),	ΔT ≦ 150
		Cooling condition Natural cooling using air cleaning, the temperatu				

No.	Process	Condition
5	Soldering	5-7. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.
		Excessive solder Higher tensile force in chip capacitors to cause crack
		Adequate Maximum amount Minimum amount
		Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.
		 5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative), Recommendations to prevent the tombstone phenomenon.)

No.	Process		Condition				
6	Solder repairing	(also called a "blower") ra					
		capacitor compared to u capacitor uniformly with stress caused by quick the Moreover, where ultra-si circuit board, reworking	Reworking using a spot heater may suppress the occurrence of cracks in the capacitor compared to using a soldering iron. A spot heater can heat up a capacitor uniformly with a small heat gradient which leads to lower thermal stress caused by quick heating and cooling or localized heating. Moreover, where ultra-small capacitors are mounted close together on a printed circuit board, reworking with a spot heater can eliminate the risk of direct contact between the tip of a soldering iron and a capacitor.				
		capacitor may occur due such an occurrence. Keep more than 5mm be The blower temperature. The airflow shall be set a The diameter of the nozis standard and common Duration of blowing hot C2012(CC0805) and C3C4532(CC1812) and C5C4532(CC1812) and C5C452(CC1812) and C5C452(CC1	zle is recommended to be 2mm(one-outlet type). The size in. air is recommended to be 10s or less for C1608(CC0603), in 216(CC1206), and 30s or less for C3225(CC1210), in 2750(CC2220), considering surface area of the capacitor is of solder. In ozzle and the capacitor is recommended to be ork easily and to avoid partial area heating. In grant soldering iron, preheating reduces thermal stress on				
		·	condition (Consult the component manufactures for details.)				
		Distance from nozzle	5mm and over				
		Nozzle angle	45degrees				
		Nozzle temp.	400°C and less				
		Airflow	Set as weak as possible (The airflow shall be the minimum value necessary for solder to melt in the conditions mentioned above.)				
		Nozzle diameter	ø2mm (one-outlet type)				
		Blowing duration	10s and less (C1608[CC0603], C2012[CC0805], C3216[CC1206]) 30s and less (C3225[CC1210], C4532[CC1812], C5750[CC2220])				
		• Example of recomme	One-outlet type nozzle Angle: 45degrees				
		Excess solder causes m in cracks. Insufficient so substrate and may result of the printed wiring boars.	I be suitable to from a proper fillet shape. echanical and thermal stress on a capacitor and results older causes weak adherence of the capacitor to the t in detachment of a capacitor and deteriorate reliability rd. ropriate solder fillet shape for 5-5.Amount of solder.				

No.	Process				Condition		
6	Solder repairing	6-2. Solder repair by	solder	iron			
		1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition.					
		Manual soldering (Solder iron)					
		Peak Temp O O O O O O O O O O O O O O O O O O					
		Recommended	solde	riron co	ndition (Sn-Pb So	lder and Lead F	ree Solder)
		Case size	Tem	p. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)
		C1005(CC0402) C1608(CC0603) C2012(CC0805) C3216(CC1206)	1005(CC0402) 1608(CC0603) 2012(CC0805) 350 max.				
		C3225(CC1210) C4532(CC1812) C5750(CC2220)	280	max.			
		* Please preheat the chip capacitors with the condition in 6-3 to avoid the thermal shock. 2) Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.					d the thermal
		6-3. Avoiding thermal shock					
		Preheating condition					
		Soldering Case size Temp. (°C)					Temp. (°C)
		Manual solde	Manual soldering $C1005(CC0402),C1608(CC0603), \\ C2012(CC0805),C3216(CC1206) \\ \hline C2012(CC0805),C3216(CC0805) \\ \hline C2012(CC0805) \\ \hline C2012(CC0805) \\ \hline C2012(CC0805) \\ \hline C2012(CC0805) \\ \hline C201$				ΔT ≦ 150
					CC1210), C4532(C CC2220)	C1812),	ΔT ≦ 130

No.	Process	Condition
7	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing (1) Terminal electrodes may corrode by Halogen in the flux.
		(1) Terminal electrodes may corrode by halogen in the liux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/l max.
		Frequency : 40 kHz max. Washing time : 5 minutes max.
		 If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
8	Coating and	1) When the P.C.board is coated, please verify the quality influence on the product.
	molding of the P.C.board	Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.
		3) Please verify the curing temperature.

No.	Process		Condition			
9	Handling after chip mounted Caution	, ,	not to bend or distort the P.C. e chip capacitors may crack.	_		
		 2) Printed circuit board cropping should not be carried out by hand, but by using the proper tooling. Printed circuit board cropping should be carried out using a board cropping jig as shown in the following figure or a board cropping apparatus to prevent inducing mechanical stress on the board. (1)Example of a board cropping jig Recommended example: The board should be pushed from the back side, close to the cropping jig so that the board is not bent and the stress applied to the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig and the pushing direction is from the front side of the board, large tensile stress is applied to the capacitor, which may cause cracks. 				
		Outline of jig Printed circuit board Slot Outline of jig V-groove Board cropping jig	Printed circuit board Components Load point V-groove Slot	Unrecommended Load point Printed circuit board V-groove Slot		

	ı	1						
No.	Process			Conditio	n			
9	Handling after chip mounted Caution	An o top a V-gro Unred botto	mple of a board cropping machine outline of a printed circuit board cropping machine is shown below. The and bottom blades are aligned with one another along the lines with the rooves on printed circuit board when cropping the board. ecommended example: Misalignment of blade position between top anom, right and left, or front and rear blades may cause a crack in the acitor.					
			Outline of mad	chine	Princip	ole of operation		
			Prin	Top Prin blade	ted circuit board	op blade 0 ttom blade		
			Cross-section diagram					
					Printed circuit be	oard	blade	
			V-groove					
			Recommended		Unrecommended	ecommended		
				Top-bottom misalignment	Left-right misalignment	Front-rear misalignment		
			Board Boatd Bottom blade	Top blade Bottom blade	Top blade Bottom blade	Top blade Bottom blade		
		to be adju	nctional check of usted higher for for the the P.C.board, it ons off. Please ac	ear of loose cor may crack the	ntact. But if the chip capacitor	pressure is exc s or peel the	cessive	
		Item	Not recon	nmended	Re	commended		
		Board bending		Termination peeling Support pin				
				Check pin		∐ ← Chec	ck pin	

No.	Process	Condition
10	Handling of loose chip capacitors	If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Crack Floor
		Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack. Crack Crack
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

operation of equipment 2) 1 3) (t equipment 4 Others	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor. The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit. Confirm that the environment to which the equipment will be exposed during ransportation and operation meets the specified conditions. Do not to use the
3) Control of the policy of th	contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit. Confirm that the environment to which the equipment will be exposed during
14 Others Caution The pelectro applia equipi	
Caution electron applia equipo	equipment in the following environments. 1) Environment where a capacitor is spattered with water or oil 2) Environment where a capacitor is exposed to direct sunlight 3) Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation 4) Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) 5) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. 6) Atmosphere change with causes condensation
applic level of serious responsitions of this spelow in this spelo	roducts listed on this specification sheet are intended for use in general onic equipment (AV equipment, telecommunications equipment, home inces, amusement equipment, computer equipment, personal equipment, office ment, measurement equipment, industrial robots) under a normal operation and ondition. roducts are not designed or warranted to meet the requirements of the lations listed below, whose performance and/or quality require a more stringent of safety or reliability, or whose failure, malfunction or trouble could cause is damage to society, person or property. Please understand that we are not nesible for any damage or liability caused by use of the products in any of the lations below or for any other use exceeding the range or conditions set forth in pecification sheet. If you intend to use the products in the applications listed or if you have special requirements exceeding the range or conditions set forth specification, please contact us. Prospace/Aviation equipment (cars, electric trains, ships, etc.) Redical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) Representation control equipment equipment control equipment enaportation control equipment enaportation control equipment electric heating apparatus, burning equipment classifications that are not considered general-purpose applications

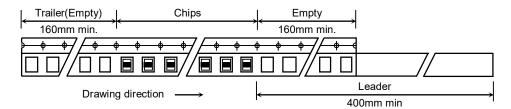
13. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4. Dimensions of plastic tape shall be according to Appendix 5, 6.

1-2. Bulk part and leader of taping

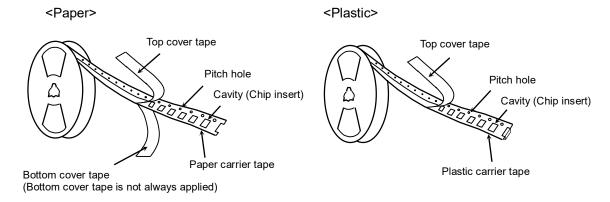


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8.

Dimensions of Ø330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping

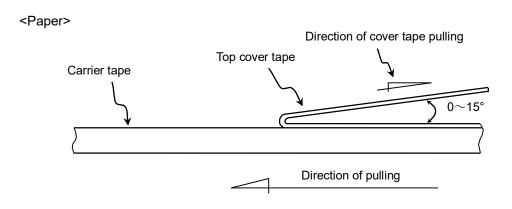


2. CHIP QUANTITY

Please refer to detail page on TDK web.

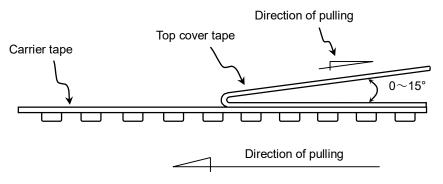
3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05N < Peeling strength < 0.7N

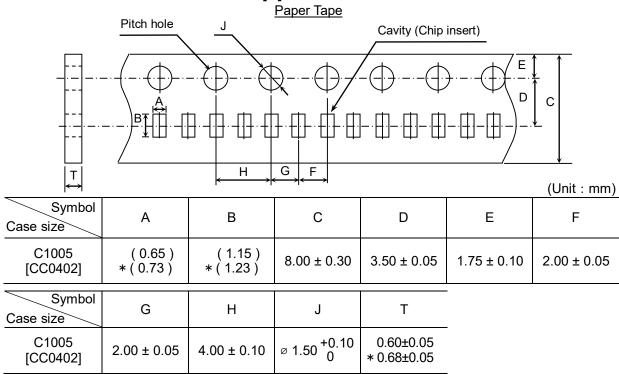


Paper tape should not adhere to top cover tape when pull the cover tape.

<Plastic>



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

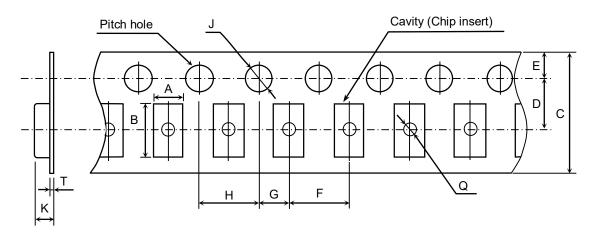


^() Reference value.

Appendix 4 Paper Tape Cavity (Chip insert) Pitch hole Т Н G F (Unit: mm) Symbol F Α В С D Ε Case size C1608 (1.10)(1.90)[CC0603] C2012 3.50 ± 0.05 8.00 ± 0.30 1.75 ± 0.10 4.00 ± 0.10 (1.50)(2.30)[CC0805] C3216 (1.90)(3.50)[CC1206] Symbol G Н J Τ Case size C1608 [CC0603] C2012 \emptyset 1.50 $^{+0.10}_{0}$ 4.00 ± 0.10 2.00 ± 0.05 1.20 max. [CC0805] C3216 [CC1206]) Reference value.

^{*} Applied to thickness, 0.50±0.10mm and 0.50 +0.15,-0.10mm products.

Plastic Tape



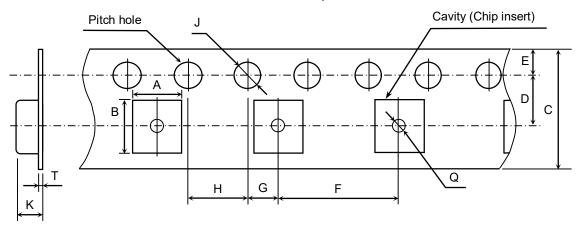
						(Unit : mm)
Symbol Case size	Α	В	С	D	E	F
C2012 [CC0805]	(1.50)	(2.30)	90103	3 5 1 0 05		
C3216 [CC1206]	(1.90)	(3.50)	8.0 ± 0.3 *12.0 ± 0.3	3.5 ± 0.05 *5.5 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 [CC1210]	(2.90)	(3.60)	12.0 ± 0.5	0.0 ± 0.00		
		l .				
Symbol Case size	G	Н	J	К	Т	Q
,	G			0.50	Т	Q
Case size C2012	G 2.00 ± 0.05		J ∅ 1.50 ^{+0.10}	0.50	T 0.60 max.	Q ∅ 0.50 min.

() Reference value.

* Applied to thickness, 2.5mm products.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

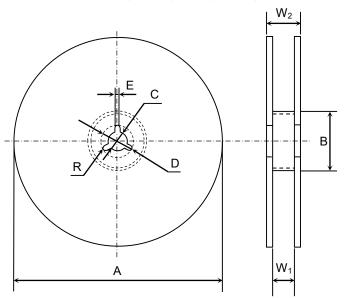
Plastic Tape



├						(Unit : mm)
Symbol Case size	Α	В	С	D	E	F
C4532 [CC1812]	(3.60)	(4.90)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
C5750 [CC2220]	(5.40)	(6.10)	12.0 ± 0.30	3.30 ± 0.03	1.73 ± 0.10	8.00 ± 0.10
Symbol Case size	G	Н	J	К	Т	Q
C4532 [CC1812]	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 ^{+0.10}	6.50 max.	0.60 max.	ø 1.50 min.
C5750 [CC2220]	2.00 £ 0.03	4.00 £ 0.10	0	0.50 IIIax.	0.00 IIIax.	₩ 1. 50 Hilli.

() Reference value. Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225

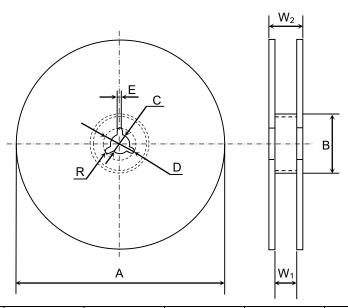


	I		ı			(Unit: mm)
Symbol	Α	В	С	D	Е	W_1
Dimension	ø 178 ± 2.0	ø 60 ± 2.0	ø 13 ± 0.5	∅ 21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W_2	R	
Dimension	13.0 ± 1.4	1.0	

Appendix 8

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750



 $\begin{array}{c|c} & \text{(Unit : mm)} \\ \hline E & W_1 \\ \hline 2.0 \pm 0.5 & 13.0 \pm 0.3 \end{array}$

Symbol	W_2	R
Dimension	17.0 ± 1.4	1.0

Symbol

Dimension

С

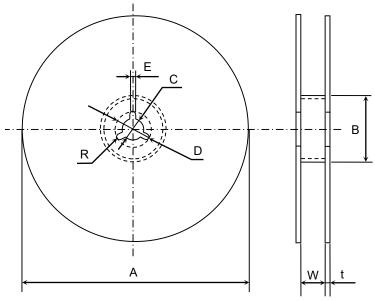
ø 13 ± 0.5

D

ø 21 ± 0.8

В

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225



 Symbol
 A
 B
 C
 D
 E
 W

 Dimension

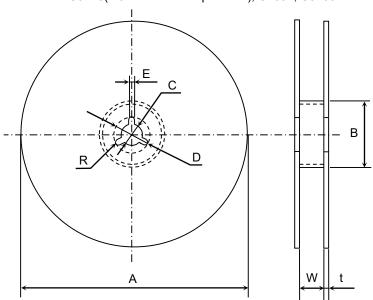
 ^Ø 382 max. (Nominal Ø 330)

 Ø 50 min.
 Ø 13 ± 0.5
 Ø 21 ± 0.8
 2.0 ± 0.5
 10.0 ± 1.5

Symbol	t	R
Dimension	2.0 ± 0.5	1.0

Appendix 10

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750



 Symbol
 A
 B
 C
 D
 E
 W

 Dimension

 ^Ø 382 max. (Nominal Ø 330)

 Ø 50 min.
 Ø 13 ± 0.5
 Ø 21 ± 0.8
 2.0 ± 0.5
 14.0 ± 1.5

Symbol	t	R
Dimension	2.0 ± 0.5	1.0

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NMC0402X7R153K16TRPF NMC0603NPO101F50TRPF NMC0603NPO1R8C50TRPF NMC0603NPO201J50TRPF

NMC0603X5R475M6.3TRPF NMC0805NPO270J50TRPF NMC0805NPO681F50TRPF NMC0805NPO820J50TRPF

NMC0805X7R224K16TRPLPF NMC0805X7R224K25TRPF NMC1206X7R102K50TRPF NMC1206X7R475K10TRPLPF NMC-Q0402NPO8R2D200TRPF C1206C101J1GAC C1608C0G2A221J C1608X7R1E334K C2012C0G2A472J 2220J2K00562KXT

CDR04BX104AKSR CDR31BX103AKWR CDR33BX683AKUS CGA2B2C0G1H010C CGA2B2C0G1H040C CGA2B2C0G1H050C

CGA2B2C0G1H060D CGA2B2C0G1H070D CGA2B2C0G1H120J CGA2B2C0G1H151J CGA2B2C0G1H1R5C CGA2B2C0G1H2R2C

CGA2B2C0G1H390J CGA2B2C0G1H391J CGA2B2C0G1H3R3C CGA2B2C0G1H680J CGA2B2C0G1H6R8D CGA2B2C0G1H820J

CGA2B2X8R1H152K CGA2B2X8R1H221K CGA2B2X8R1H331K CGA2B2X8R1H332K